



## 30V/28A Dual N-Channel Advanced Power MOSFET

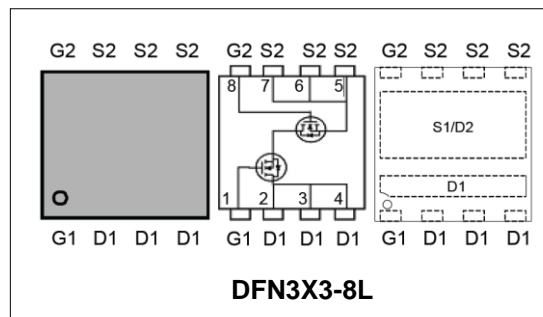
### Features

- Improved dv/dt Capability, High Ruggedness.
- Maximum Junction Temperature Range (150°C)

BVDSS	30	V
ID	28	A
RDSON@VGS=10V	6.3	mΩ
RDSON@VGS=4.5V	8.3	mΩ

### Applications

- Telecom DC/DC
- Synchronous buck converter
- POL



### Order Information

Product	Package	Marking	Reel Size	Reel	Carton
PTM3028DS	DFN3X3-8L	PTM3028DS	7inch	5000PCS	50000PCS

### Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit	
<b>Common Ratings (TC=25°C Unless Otherwise Noted)</b>				
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	30	V	
$V_{GS}$	Gate-Source Voltage	±20	V	
$T_J$	Maximum Junction Temperature	150	°C	
$T_{STG}$	Storage Temperature Range	-55 to 150	°C	
$I_S$	Diode Continuous Forward Current	TC =25°C	28	A
<b>Mounted on Large Heat Sink</b>				
$I_{DM}$	Pulse Drain Current Tested (Silicon Limit) (Note1)	TC =25°C	84	A
$I_D$	Continuous Drain current	TC =25°C	28	A
$P_D$	Maximum Power Dissipation	TC =25°C	20	W
$R_{\theta JC}$	Thermal Resistance Junction-to-Case (Note2)		6.25	°C/W



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Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
<b>Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise stated)</b>						
V <sub>(BR)DSS</sub>	Drain- Source Breakdown Voltage	VGS=0V ID=250μA	30	--	--	V
I <sub>DSS</sub>	Zero Gate Voltage Drain current	VDS=30V,VGS=0V	--	--	1	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	VGS=±20V,VDS=0V	--	--	±100	nA
V <sub>GS(TH)</sub>	Gate Threshold Voltage	VDS=VGS,ID=250μA	1	1.5	2.5	V
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance (Note3)	VGS=10V, ID=13A	--	6.3	9	mΩ
		VGS=4.5V, ID=10A	--	8.3	13	mΩ
<b>Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise stated) (Note5)</b>						
C <sub>iss</sub>	Input Capacitance	VDS=15V, VGS=0V, F=1MHz	--	983	--	pF
C <sub>oss</sub>	Output Capacitance		--	207	--	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		--	121	--	pF
Q <sub>g</sub>	Total Gate Charge	VDS=15V, ID=5A, VGS=10V	--	28	--	nC
Q <sub>gs</sub>	Gate-Source Charge		--	7	--	nC
Q <sub>gd</sub>	Gate-Drain Charge		--	5	--	nC
<b>Switching Characteristics (Note5)</b>						
t <sub>d(on)</sub>	Turn-on Delay Time	VDS=20V, ID=10A, RG=3Ω, VGS=10V	--	8	--	nS
t <sub>r</sub>	Turn-on Rise Time		--	15	--	nS
t <sub>d(off)</sub>	Turn-off Delay Time		--	27	--	nS
t <sub>f</sub>	Turn-off Fall Time		--	7	--	nS
<b>Source- Drain Diode Characteristics @ T<sub>J</sub> = 25°C (unless otherwise stated)</b>						
V <sub>SD</sub>	Forward on voltage	IS=15A,VGS=0V	--	0.85	1.2	V

Note:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, t ≤ 10 sec.
3. Pulse Test: pulse width ≤ 300 us, duty cycle ≤ 2%.
4. Guranteed by design, not subject to production testing.



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Typical Characteristics

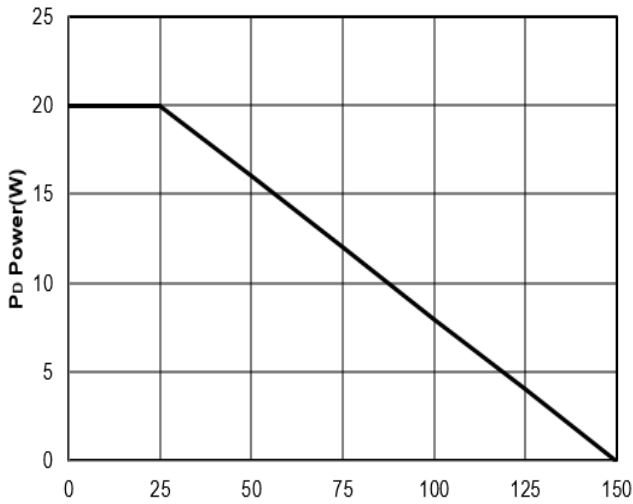


Figure1: Tj Junction Temperature (°C)

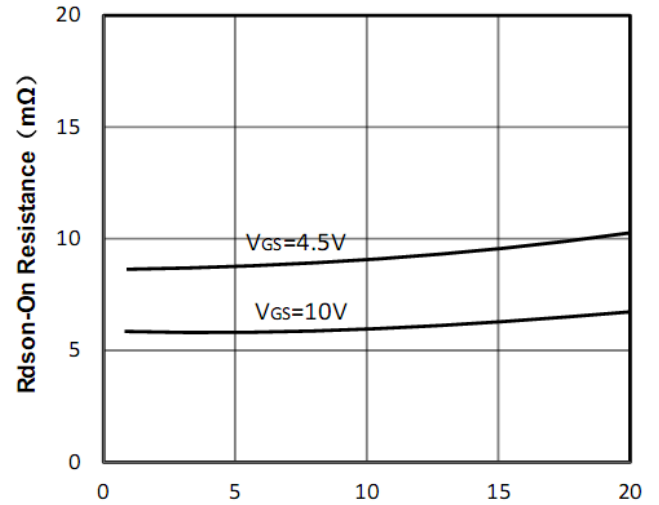


Figure2: Id Drain Current (A)

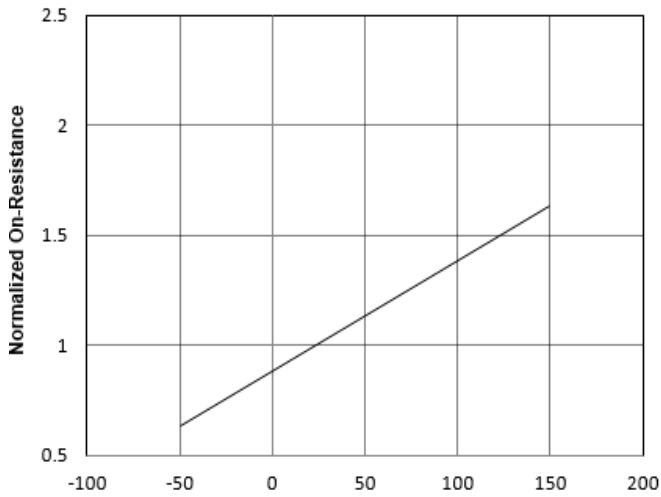


Figure3: Tj Junction Temperature (°C)

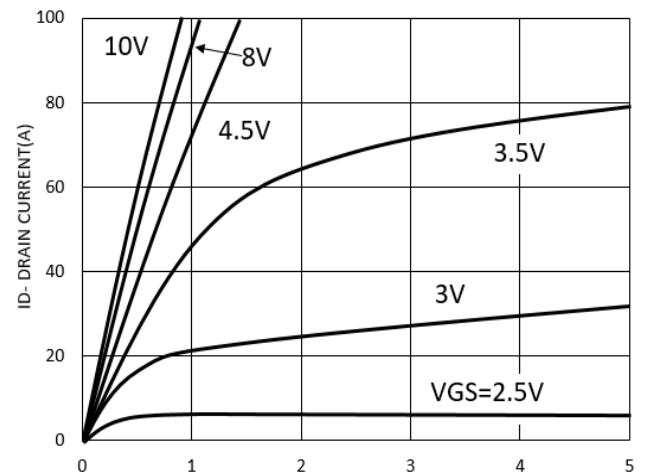


Figure4: Vds Drain-Source Voltage (V)

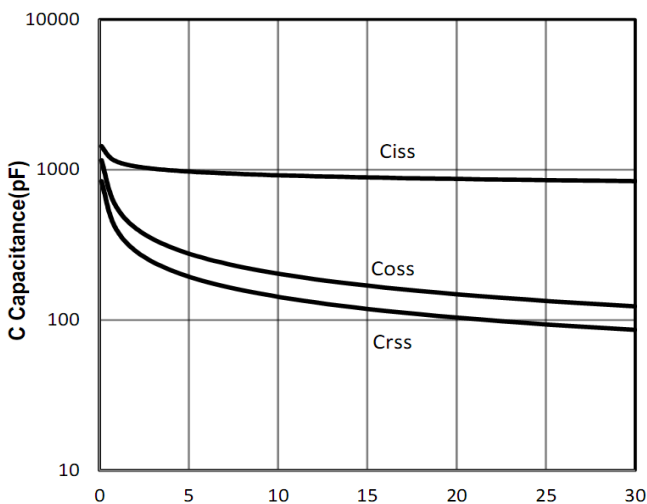


Figure5: Vds Drain-Source Voltage (V)

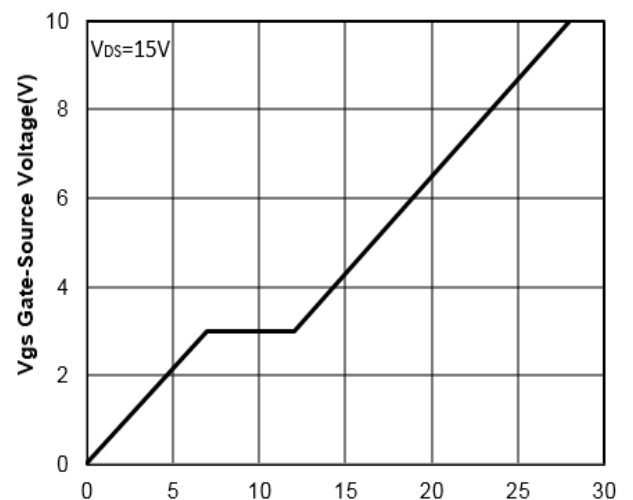


Figure6: Qg Gate Charge (nC)



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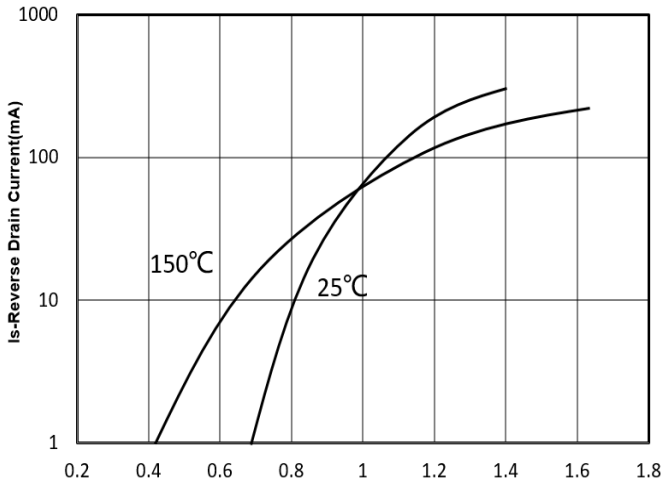


Figure7: Vsd Source-Drain Voltage (V)

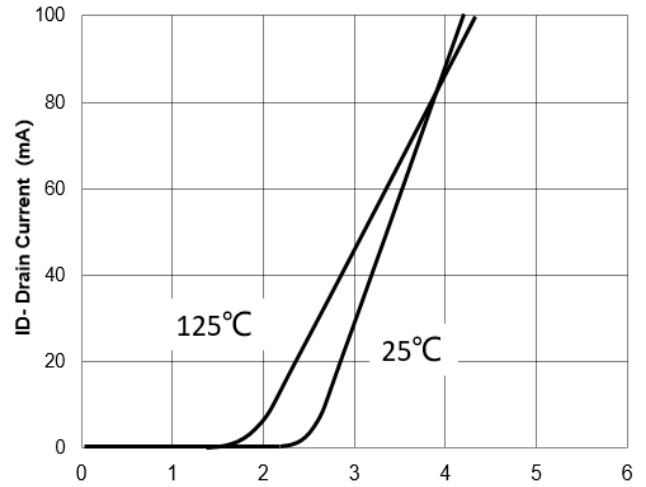


Figure8: Vgs Gate-Source Voltage (V)

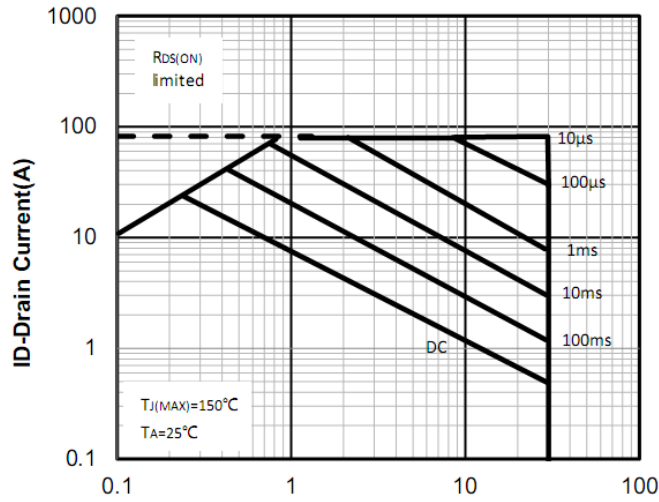


Figure9: VDS Drain -Source Voltage (V)

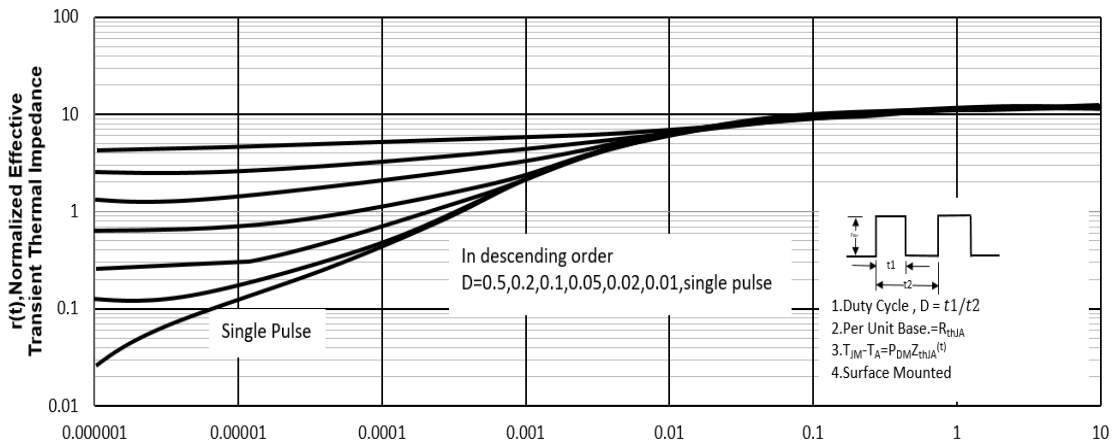


Figure10: Square Wave Pulse Duration (sec)

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### Test Circuit and Waveform:

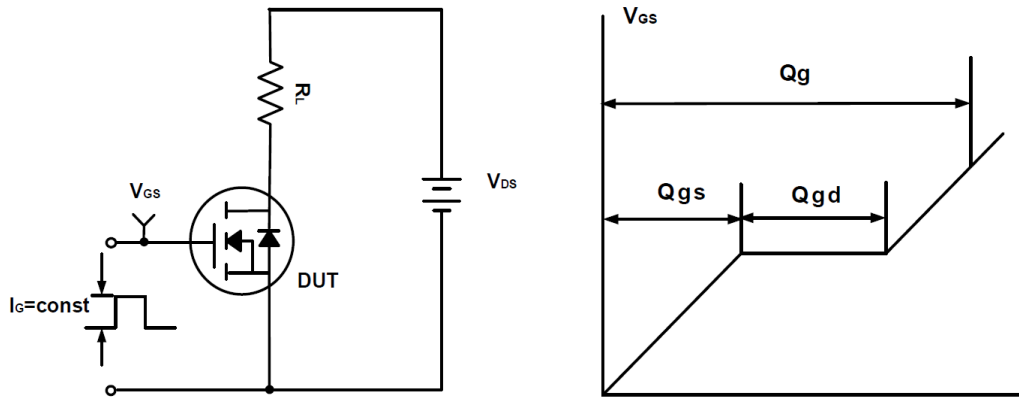


Figure A Gate Charge Test Circuit & Waveforms

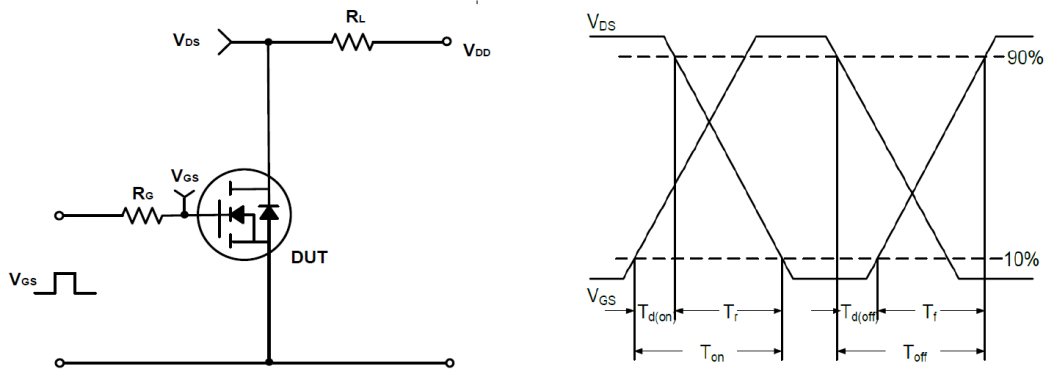
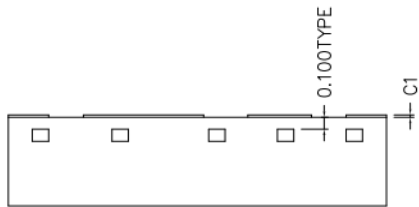
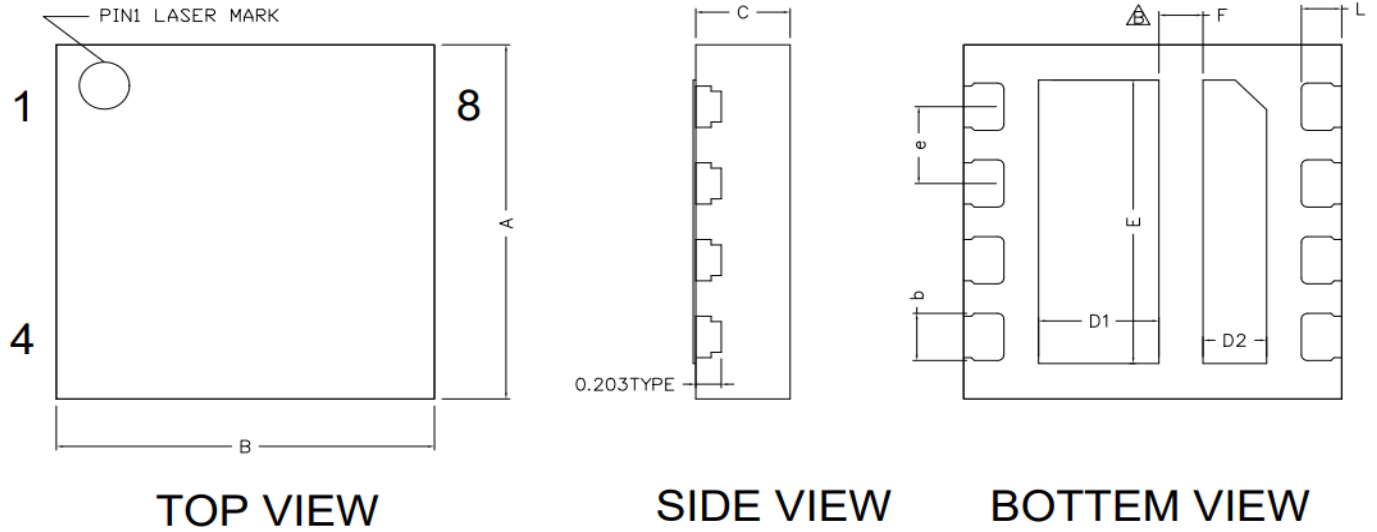


Figure B Switching Test Circuit & Waveforms



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DFN3X3-8L Package Outline Dimensions (Units: mm)



SIDE VIEW

	MIN	NORMAL	MAX
A	2.900	3.000	3.100
B	2.900	3.000	3.100
C	0.700	0.750	0.800
C1	0.005	—	0.020
D1	0.855	0.955	1.055
D2	0.405	0.505	0.605
E	2.300	2.400	2.500
F	0.35 TYPE		
L	0.270	0.320	0.370
b	0.350	0.400	0.450
e	0.650 TYPE		